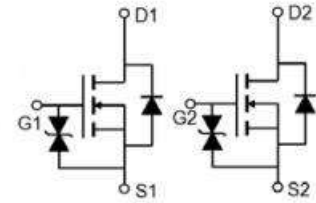


Feature

- 50V,0.4A
 $R_{DS(ON)} < 2.8 \Omega @ V_{GS}=10V$ TYP:1.4 Ω
 $R_{DS(ON)} < 4.0 \Omega @ V_{GS}=4.5V$ TYP:1.8 Ω
 $R_{DS(ON)} < 4.5 \Omega @ V_{GS}=3.3V$ TYP:2.2 Ω
- Advanced Trench Technology
- 5V Logic Level Control
- Lead free product is acquired
- ESD Protected



Schematic Diagram



SOT-363 top view

Application

- Interfacing Switching
- ON/OFF Switching
- Logic Level shift

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity (PCS)
-	AP138KDW	Sot-363	7 inch	-	-

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	50	V
Gate-Source Voltage	V_{GS}	± 12	V
Continuous Drain Current ($T_a = 25^\circ\text{C}$)	I_D	0.4	A
Continuous Drain Current ($T_a = 70^\circ\text{C}$)	I_D	0.3	A
Pulsed Drain Current	I_{DM}	0.8	A
Power Dissipation	P_D	0.9	W
Thermal Resistance from Junction to Ambient ⁽⁴⁾	$R_{\theta JA}$	125	$^\circ\text{C}/\text{W}$
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~ +150	$^\circ\text{C}$

MOSFET ELECTRICAL CHARACTERISTICS($T_a=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Type	Max	Unit
Static Characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	50	-	-	V
Zero gate voltage drain current	I_{DSS}	$V_{DS} = 50V, V_{GS} = 0V$	-	-	1	μA
Gate-body leakage current	I_{GSS}	$V_{GS} = \pm 12V, V_{DS} = 0V$	-	-	± 10	μA
Gate threshold voltage ⁽³⁾	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	0.6	0.85	1.2	V
Drain-source on-resistance ⁽³⁾	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 0.4A$	-	1.4	2.8	Ω
		$V_{GS} = 4.5V, I_D = 0.3A$	-	1.8	4.0	
		$V_{GS} = 3.3V, I_D = 0.2A$		2.2	4.5	
Dynamic characteristics						
Input Capacitance	C_{iss}	$V_{DS} = 30V, V_{GS} = 0V, f = 1MHz$	-	12	-	pF
Output Capacitance	C_{oss}		-	3.2	-	
Reverse Transfer Capacitance	C_{rss}		-	0.8	-	
Switching characteristics						
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 30V, I_D = 0.3A,$ $V_{GS} = 10V, R_G = 3.3\Omega$	-	4.5	-	ns
Turn-on rise time	t_r		-	3.1	-	
Turn-off delay time	$t_{d(off)}$		-	15	-	
Turn-off fall time	t_f		-	3.3	-	
Total Gate Charge	Q_g	$V_{DS} = 30V, I_D = 0.3A,$ $V_{GS} = 4.5V$	-	0.58	-	nC
Gate-Source Charge	Q_{gs}		-	0.12	-	
Gate-Drain Charge	Q_{gd}		-	0.21	-	
Source-Drain Diode characteristics						
Diode Forward voltage ⁽³⁾	V_{DS}	$V_{GS} = 0V, I_S = 0.3A$	-	-	1.2	V
Diode Forward current ⁽³⁾	I_S		-	-	0.4	A

Notes:

1. Repetitive Rating: pulse width limited by maximum junction temperature
2. Pulse Test: pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
3. Surface Mounted on FR4 Board, $t \leq 10$ sec

Typical Characteristics

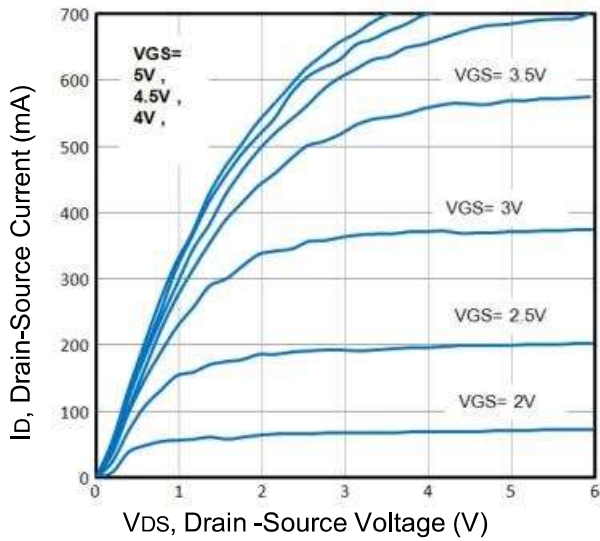


Fig1. Typical Output Characteristics

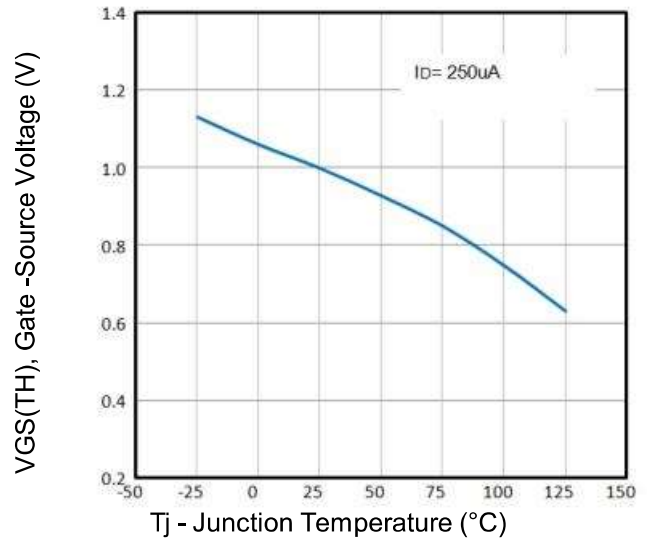


Fig2. Normalized Threshold Voltage Vs. Temperature

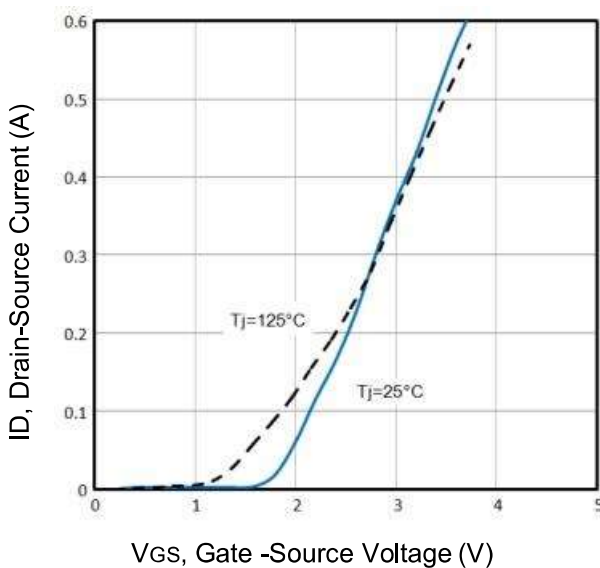


Fig3. Typical Transfer Characteristics

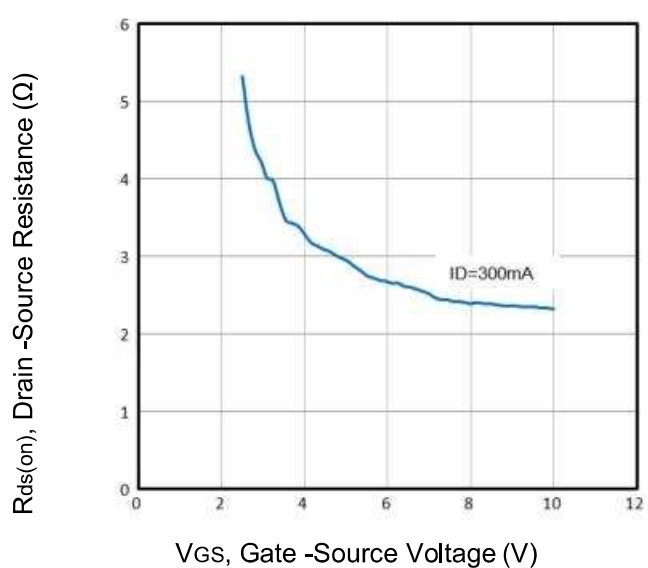


Fig4. Rds(on) vs Gate-Source Voltage

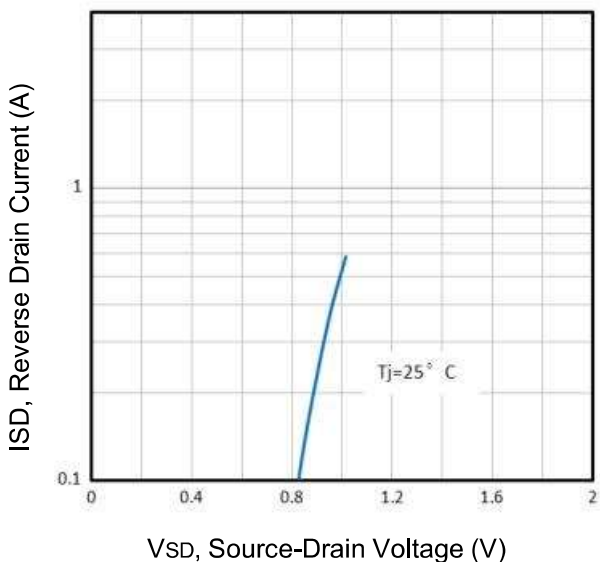


Fig5. Typical Source-Drain Diode Forward Voltage

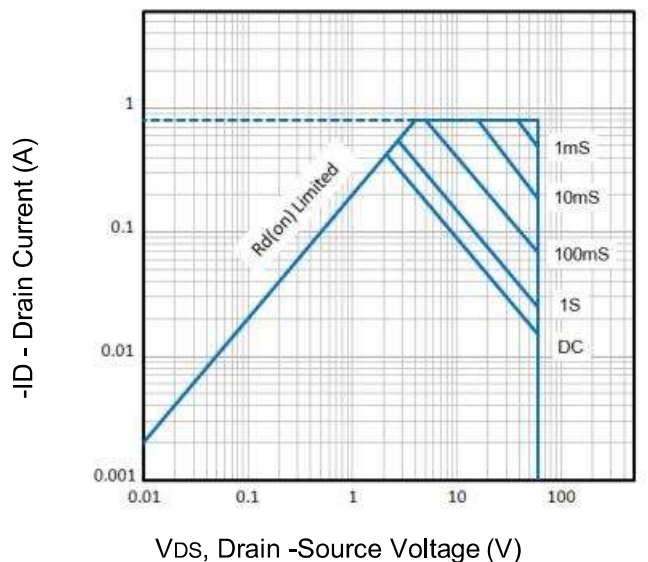


Fig6. Maximum Safe Operating Area

Typical Characteristics

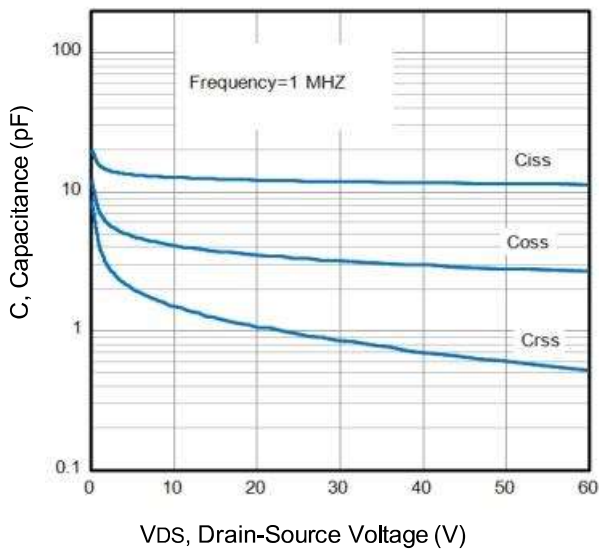


Fig7. Typical Capacitance Vs. Drain-Source Voltage

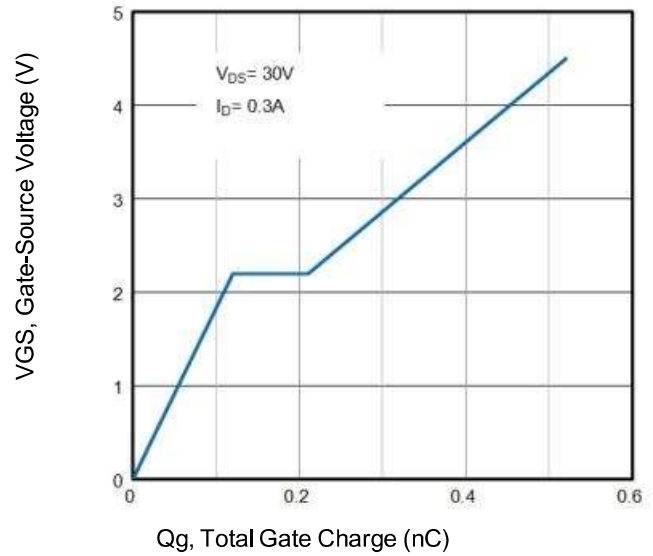


Fig8. Typical Gate Charge Vs. Gate-Source Voltage

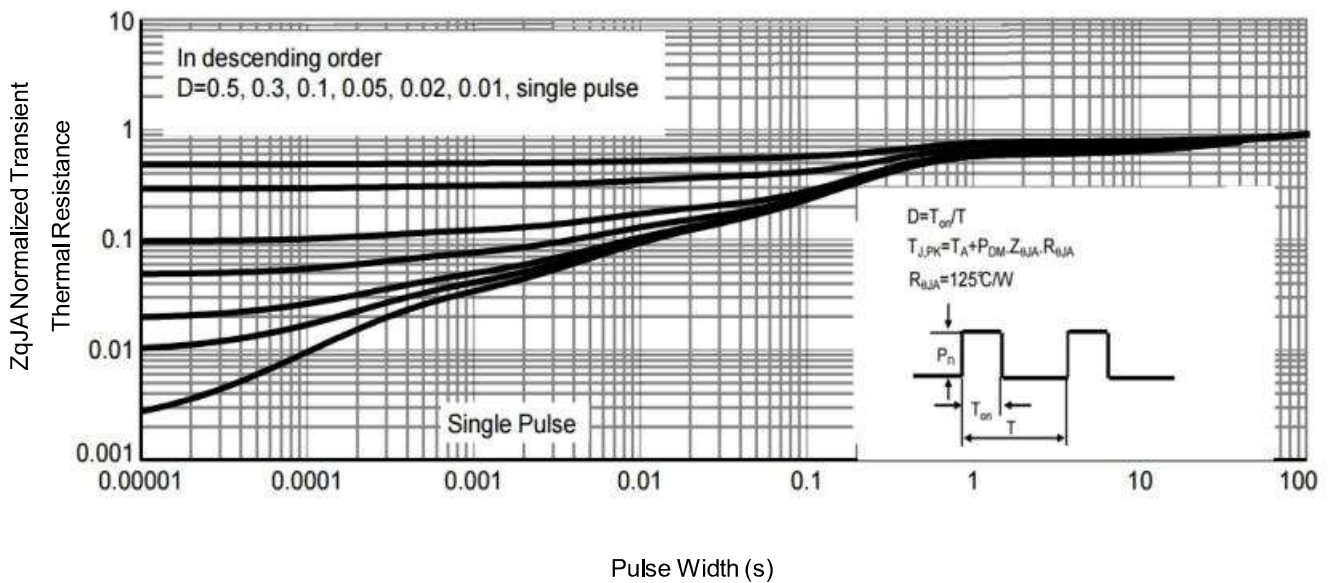


Fig9. Normalized Maximum Transient Thermal Impedance

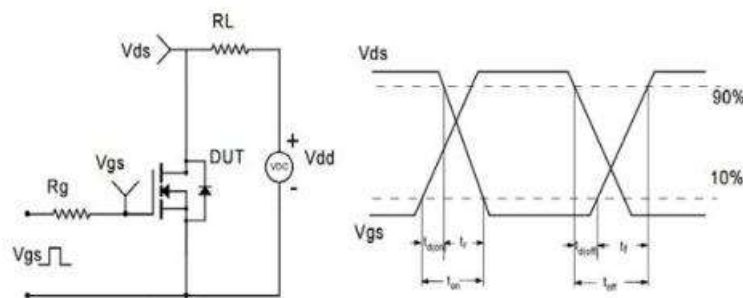
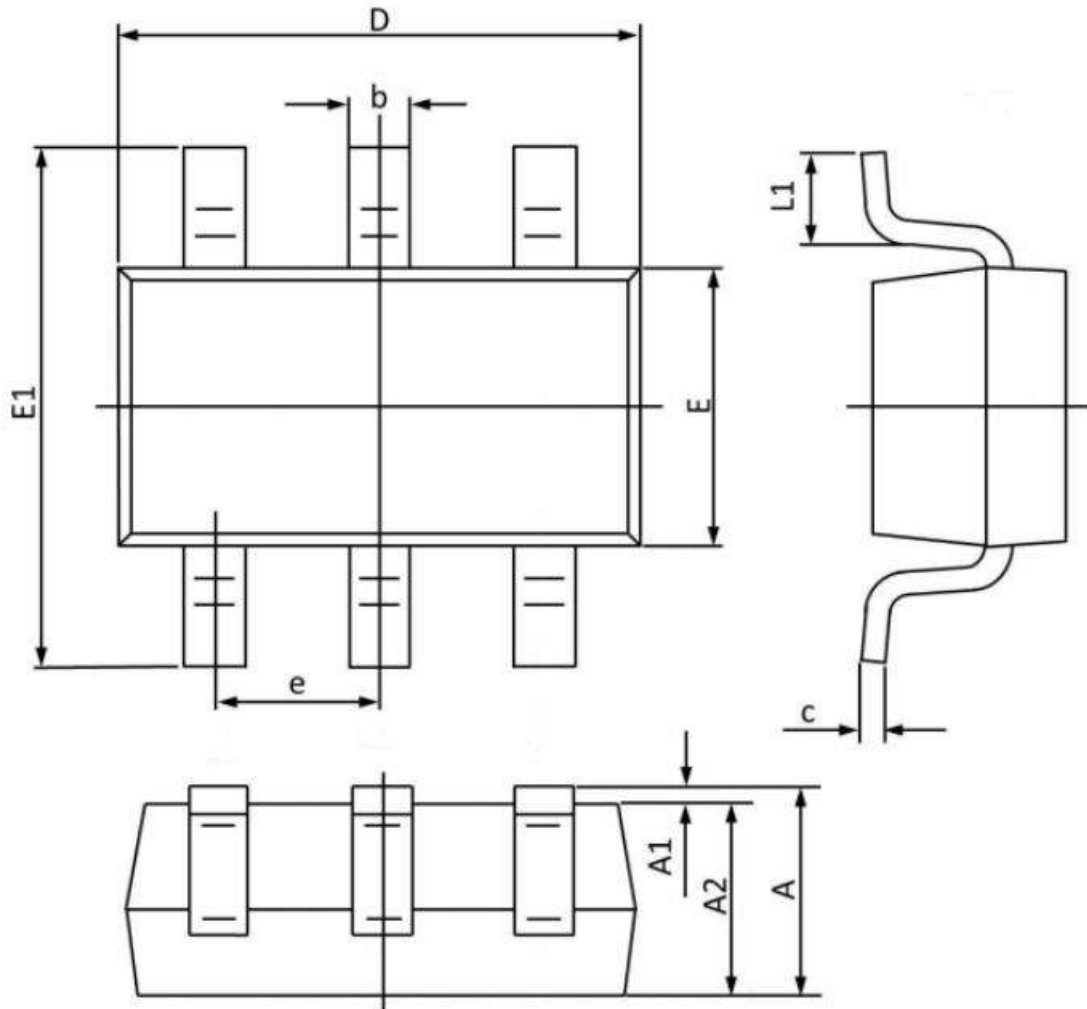


Fig10. Switching Time Test Circuit and waveforms

SOT-363 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	MAX	MIN	MAX	MIN
A	1.100	0.800	0.043	0.031
A1	0.100	0.000	0.004	0.000
A2	1.000	0.800	0.039	0.031
b	0.330	0.100	0.013	0.004
c	0.250	0.100	0.010	0.004
D	2.200	1.800	0.087	0.071
E	1.350	1.150	0.053	0.045
E1	2.400	1.800	0.094	0.071
e	0.65BSC		0.026BSC	
L1	0.350	0.100	0.014	0.004